Special Issue

Optoelectronic Materials, Devices, and Applications

Message from the Guest Editors

It is our pleasure to announce a new Special Issue of *Applied Sciences* devoted to optoelectronic materials, devices, and applications. It will cover both the theoretical and experimental advances of optoelectronic materials and devices especially about semiconductor, integrated photonics, fiber optics, power electronic devices, microwave, and terahertz technology. Particularly welcome will be works focused on applications in sensors, detections, and imaging. Taking into account that a validation of a supposition is usually realized via a cross-check, the use of combined approaches is also welcomed.

Guest Editors

Prof. Dr. Pingjuan Niu

Prof. Dr. Li Pei

Prof. Dr. Yunhui Mei

Prof. Dr. Hua Bai

Dr. Jia Shi

Deadline for manuscript submissions

closed (31 December 2022)



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About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo

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